

Notice of References Cited	Application/Control No. 09/935,686	Applicant(s)/Patent Under Reexamination KAMIYA ET AL.	
	Examiner Ted T. Vo	Art Unit 2122	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,745,320 B1	06-2004	Mitsuishi, Naoki	712/225
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	UTMC Microelectronic Systems Inc., "UT1750AR RISC Assembly Language Manual", http://wwwold.utmc.com/products/1750riscassy.pdf , pages 1-54, 10-1998
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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